

SSD Cost-of-Test Using Non-PC Based Architectures

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 Cost-Of-Test = Capital equipment focused, single point of time calculation of test costs.

Cost Of Test = Capital Equipment Cost Devices / Workcell

 Cost-Of-Ownership = Total cost to own and operate a piece of equipment over its useful life.

Cost Of Ownership =

Development + Deployment + Operational Costs Devices / Workcell

Development, e.g. research, tools, training, timeDeployment, e.g. capital equipment, software deploymentOperational, e.g. operators, maintenance, floor space, technology refresh, parallel efficiency, utilization





 PC motherboard + Protocol Board (HBA) + Test Software



- Manual insertion for <1000 SSD per Tester
- Optional Oven for Characterization and Burn-in











Approaches	Pro	Con
SFF Motherboards	< Footprint	> Cost, Heat, < Slots
Riser Cards / Extenders	< Height, Size	Signal integrity
Shrink Rack Space	> Parallelism	Heat, < Flexibility
Integrate HBA on Motherboard	< Footprint	> Cost, Fixed protocol
Shared Rails vs. Individual Supplies	< Cost	< Flexibility, Stability
HBA Sharing	> Parallelism,< Cost	Performance

SSD







- Multi-DUT SATA performance drops with >4 SSDs*
- Performance dependent on CPU, OS & SW efficiency
- * 3.7GHz i7 quad core PC w/ 8 port LSI HBA





• Write 30TB of Data, 75/25 Read/Write Mix Written Data is Read back and compared

	Full Performance	PC 1:8 Sharing	
Total Writes (TB)	30	30	
Total Reads (TB)	90	90	
Write Speed (MB/s)	IB/s) 500 350		
Read Speed (MB/s)	550	385	
Compare Overhead	0%	10%	

Write (h)	175	250
Read (h)	477	681
Compare (h)	0	68

Total Time (h)	651	999	53% Longer





Share-Resource-Tester













3 Protocol Cost Comparison



Santa Clara, CA





COO vs. # of Product Mix Changes



* Major retooling can result in testers being retired or additional new purchases





- Parallelism scaling without sacrificing performance or stability.
- Interface reconfiguration, on customer floor to enable mix product testing.
- Lower cost of ownership for multi-protocol solutions than dedicated PC testers.
- Longer tester life through tester upgradability.







- Limited technical differentiation between PC-based testers makes price the key purchasing decision for SSD test equipment.
- Advantest proposing ATE tester approach that improves Cost Of Ownership (COO) by providing:

Parallelism Scaling, Mix Product Testing and Tester-per-DUT Performance targeted at next generation multi-lane SSDs





- White Paper The Real "Total Cost of Ownership" of Your Test Equipment - Agilent Technologies 2010
- Test & Measurement World Do you know your true cost of test?, Richard McDonell, National Instruments – Nov 2009

